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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination VELIKOTNY ET AL. | |
| | | Examiner Pascal M. Bui-Pho | Art Unit 2878 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-5,563,408 | 10-1996 | Matsumoto et al. | 250/231.14 |
| * | B | US-4,654,527 | 03-1987 | Schmitt, Walter | 250/237G |
| * | C | US-6,031,224 | 02-2000 | Peterlechner, Andreas | 250/231.13 |
| * | D | US-5,294,793 | 03-1994 | Schwaiger et al. | 250/231.16 |
| * | E | US-5,068,529 | 11-1991 | Ohno et al. | 250/231.18 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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